



Test report No. : 33AE0086-HO-01-B-R1
Page : 1 of 24
Issued date : September 14, 2012
Revised date : September 24, 2012
FCC ID : HYQ2EA

RADIO TEST REPORT

Test Report No. : 33AE0086-HO-01-B-R1

Applicant : DENSO CORPORATION

Type of Equipment : Electronic Key

Model No. : 2EA

Test regulation : FCC Part 15 Subpart C: 2012

FCC ID : HYQ2EA

Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This report is a revised version of 33AE0086-HO-01-B. 33AE0086-HO-01-B is replaced with this report.

Date of test: August 10 and 19, 2012

Representative test engineer:

Shinya Watanabe
Engineer of WiSE Japan,
UL Verification Service

Approved by:

Takahiro Hatakeda
Leader of WiSE Japan,
UL Verification Service

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<http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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13-EM-F0429

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SECTION 1: Customer information

Company Name : DENSO CORPORATION
Address : 1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number : +81-566-20-3957
Facsimile Number : +81-566-25-4837
Contact Person : TAKAYUKI AONO

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Electronic Key
Model No. : 2EA
Serial No. : Refer to Clause 4.2
Rating : DC 3.0V
Receipt Date of Sample : August 10, 2012
Country of Mass-production : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: 2EA (referred to as the EUT in this report) is the Electronic Key.
The EUT (2EA) transmits radio wave signals of FSK and ASK.
The radio wave signals of FSK and ASK are not transmitted simultaneously.
Either one of FSK and ASK is transmitted by operator's action.
End users cannot control which of FSK and ASK to be transmitted.

General Specification

Clock frequency(ies) in the system : 16MHz, 13.08MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 433.92MHz
Modulation : FSK (F1D) / ASK (A1D)
Power Supply (radio part input) : DC 3.0V
Type of Battery : One lithium battery
Antenna type : Built-in type (Fixed)

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2012, final revised on July 23, 2012 and effective August 22, 2012
 Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
 Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
 and above 70MHz

* The revision on July 23, 2012 does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 IC: RSS-Gen 7.2.4	N/A	N/A*1)	-
Automatically Deactivate	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(a)(1) IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.8	FCC: Section 15.231(b) IC: RSS-210 A1.1.2	[FSK] 4.6dB 433.92MHz Horizontal PK with Duty factor [ASK] 7.1dB 433.92MHz Vertical PK with Duty factor	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.9	FCC: Section 15.205 Section 15.209 Section 15.231(b) IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 7.2.5	[FSK] 4.2dB 3037.440MHz Vertical PK with Duty factor [ASK] 6.9dB 3905.280MHz Vertical PK with Duty factor	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators KDB 926416 IC: -	FCC: Section 15.231(c) IC: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

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FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.3dB	5.0dB	5.1dB	4.9dB	5.8dB	4.4dB	4.3dB
No.2	4.3dB	5.2dB	5.1dB	5.0dB	5.7dB	4.3dB	4.2dB
No.3	4.6dB	5.0dB	5.1dB	5.0dB	5.7dB	4.5dB	4.2dB
No.4	4.8dB	5.2dB	5.0dB	5.0dB	5.7dB	5.2dB	4.2dB

*3m/1m/0.5m = Measurement distance

Radiated emission test(3m)

[FSK]

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

[ASK]

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, Test instruments.

Refer to APPENDIX.

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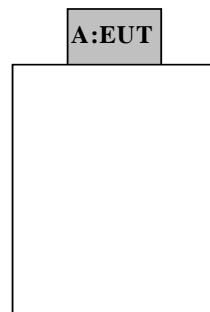
SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate Duty Cycle	Transmitting mode, FSK/ASK, 433.92MHz
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth	Transmitting mode, FSK/ASK, 433.92MHz *1)

* The system was configured in typical fashion (as a customer would normally use it) for testing.
 *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transceiver button is being pressed (For Normal use mode, EUT stops when transceiver button is being pressed.)
 End users cannot change the settings of the output power of the product.

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Electronic Key	2EA	001	DENSO CORPORATION	EUT

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the tabletop.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

Photographs of the set up are shown in Appendix 1.

[Transmitting mode]

(Below 30MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined. Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz	Above 1GHz
Detector Type	Peak	Peak	Peak	Peak	QP	Peak and AV
IF Bandwidth	200Hz	200Hz	9.1kHz	9.1kHz	120kHz	PK: S/A:RBW 1MHz, VBW 3MHz AV: S/A:RBW 1MHz, VBW 10MHz

- The carrier level was measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test with mechanical key was the worst case. Therefore the test with mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range	: 9kHz-3.2GHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20dB and 99% Occupied Bandwidth

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20dB Bandwidth	300kHz	3kHz	9.1kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 % of Span	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100%.

Test data : APPENDIX
Test result : Pass

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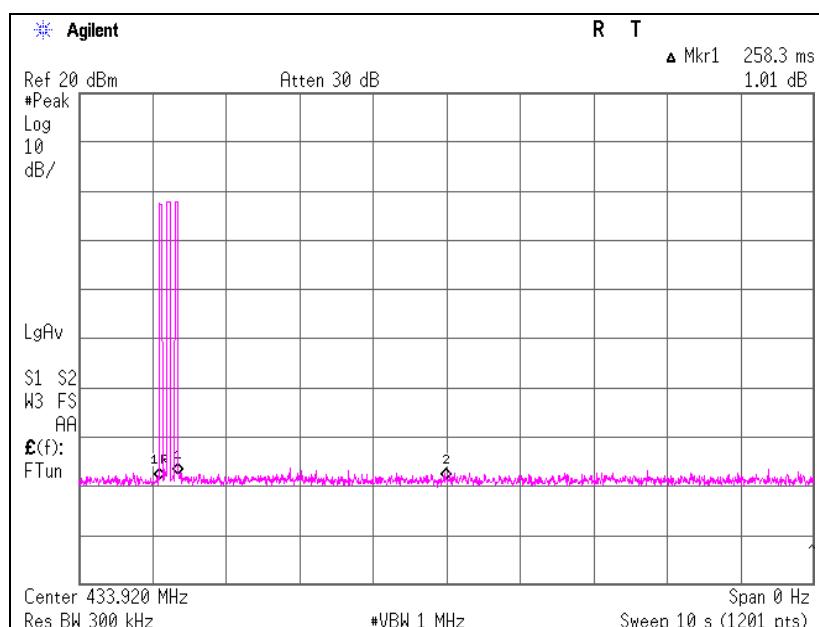
Facsimile : +81 596 24 8124

APPENDIX 1: Data of EMI test

Automatically deactivate

Test place No.3 Semi Anechoic Chamber
Report No. 33AE0086-HO-01
Date 08/19/2012
Temperature/ Humidity 22 deg. C / 71% RH
Engineer Shinya Watanabe
Mode Transmitting mode, FSK (433.92MHz)

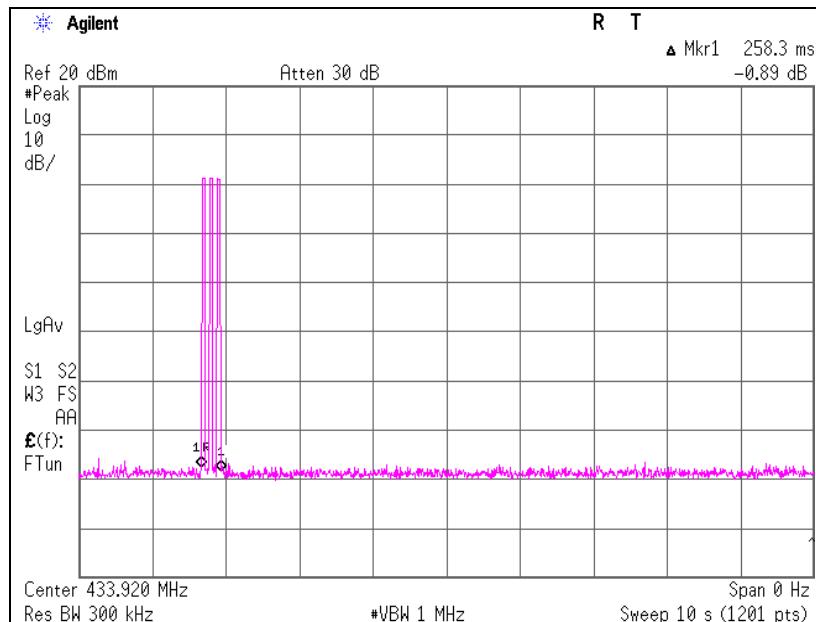
Time of Transmitting [sec]	Limit [sec]	Result
0.258	5.00	Pass



Automatically deactivate

Test place No.3 Semi Anechoic Chamber
Report No. 33AE0086-HO-01
Date 08/19/2012
Temperature/ Humidity 22 deg. C / 71% RH
Engineer Shinya Watanabe
Mode Transmitting mode, ASK (433.92MHz)

Time of Transmitting [sec]	Limit [sec]	Result
0.258	5.00	Pass



Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place Head Office EMC Lab. No.4 Semi Anechoic Chamber (Below 1GHz)
Report No. 33AE0086-HO-01
Date 08/10/2012 / 08/19/2012
Temperature/ Humidity 24 deg. C / 59% RH / 22 deg. C / 71% RH
Engineer Shinya Watanabe
Mode Transmitting mode, FSK (433.92MHz)

PK													
Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
433.920	PK	88.7	88.6	18.1	10.5	31.9	-	85.4	85.3	100.8	15.4	15.5	Carrier
867.840	PK	40.4	37.3	24.0	12.7	31.4	-	45.7	42.6	80.8	35.1	38.2	Outside
1735.680	PK	51.1	53.4	25.6	1.9	33.1	-	45.5	47.8	80.8	35.3	33.0	Outside
2169.600	PK	59.1	59.6	26.6	2.1	32.5	-	55.3	55.8	80.8	25.5	25.0	Outside
2603.520	PK	61.2	60.7	28.1	2.3	32.3	-	59.3	58.8	80.8	21.5	22.0	Outside
3037.440	PK	65.4	66.2	29.2	2.5	32.1	-	65.0	65.8	80.8	15.8	15.0	Outside
3471.360	PK	52.4	50.2	28.7	2.7	31.9	-	51.9	49.7	80.8	28.9	31.1	Outside
3905.280	PK	54.6	57.4	29.6	2.8	31.7	-	55.3	58.1	73.9	18.6	15.8	Inside
4339.200	PK	50.4	51.5	30.2	3.0	31.6	-	52.0	53.1	73.9	21.9	20.8	Inside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amprifier)

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
		433.920	PK	88.7	88.6	18.1	10.5	31.9	-9.2	76.2	76.1	80.8	4.6
867.840	PK	40.4	37.3	24.0	12.7	31.4	-9.2	36.5	33.4	60.8	24.3	27.4	Outside
1735.680	PK	51.1	53.4	25.6	1.9	33.1	-9.2	36.3	38.6	60.8	24.5	22.2	Outside
2169.600	PK	59.1	59.6	26.6	2.1	32.5	-9.2	46.1	46.6	60.8	14.7	14.2	Outside
2603.520	PK	61.2	60.7	28.1	2.3	32.3	-9.2	50.1	49.6	60.8	10.7	11.2	Outside
3037.440	PK	65.4	66.2	29.2	2.5	32.1	-9.2	55.8	56.6	60.8	5.0	4.2	Outside
3471.360	PK	52.4	50.2	28.7	2.7	31.9	-9.2	42.7	40.5	60.8	18.1	20.3	Outside
3905.280	PK	54.6	57.4	29.6	2.8	31.7	-9.2	46.1	48.9	53.9	7.8	5.0	Inside
4339.200	PK	50.4	51.5	30.2	3.0	31.6	-9.2	42.8	43.9	53.9	11.1	10.0	Inside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB)

*No signal detected at 9kHz - 30MHz.

* Third harmonics was not detected.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place Head Office EMC Lab. No.4 Semi Anechoic Chamber (Below 1GHz)
 / No.3 Semi Anechoic Chamber (Above 1GHz)
 Report No. 33AE0086-HO-01
 Date 08/10/2012 / 08/19/2012
 Temperature/ Humidity 24 deg. C / 59% RH / 22 deg. C / 71% RH
 Engineer Shinya Watanabe
 Mode Transmitting mode, ASK (433.92MHz)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
433.920	PK	92.0	92.1	18.1	10.5	31.9	-	88.7	88.8	100.8	12.1	12.0	Carrier
867.840	PK	43.6	42.8	24.0	12.7	31.4	-	48.9	48.1	80.8	31.9	32.7	Outside
1735.680	PK	56.1	57.7	25.6	1.9	33.1	-	50.5	52.1	80.8	30.3	28.7	Outside
2169.600	PK	63.8	64.4	26.6	2.1	32.5	-	60.0	60.6	80.8	20.8	20.2	Outside
2603.520	PK	65.6	65.2	28.1	2.3	32.3	-	63.7	63.3	80.8	17.1	17.5	Outside
3037.440	PK	67.3	67.4	29.2	2.5	32.1	-	66.9	67.0	80.8	13.9	13.8	Outside
3471.360	PK	54.6	52.8	28.7	2.7	31.9	-	54.1	52.3	80.8	26.7	28.5	Outside
3905.280	PK	59.2	61.4	29.6	2.8	31.7	-	59.9	62.1	73.9	14.0	11.8	Inside
4339.200	PK	52.3	54.2	30.2	3.0	31.6	-	53.9	55.8	73.9	20.0	18.1	Inside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
433.920	PK	92.0	92.1	18.1	10.5	31.9	-15.1	73.6	73.7	80.8	7.2	7.1	Carrier
867.840	PK	43.6	42.8	24.0	12.7	31.4	-15.1	33.8	33.0	60.8	27.0	27.8	Outside
1735.680	PK	56.1	57.7	25.6	1.9	33.1	-15.1	35.4	37.0	60.8	25.4	23.8	Outside
2169.600	PK	63.8	64.4	26.6	2.1	32.5	-15.1	44.9	45.5	60.8	15.9	15.3	Outside
2603.520	PK	65.6	65.2	28.1	2.3	32.3	-15.1	48.6	48.2	60.8	12.2	12.6	Outside
3037.440	PK	67.3	67.4	29.2	2.5	32.1	-15.1	51.8	51.9	60.8	9.0	8.9	Outside
3471.360	PK	54.6	52.8	28.7	2.7	31.9	-15.1	39.0	37.2	60.8	21.8	23.6	Outside
3905.280	PK	59.2	61.4	29.6	2.8	31.7	-15.1	44.8	47.0	53.9	9.1	6.9	Inside
4339.200	PK	52.3	54.2	30.2	3.0	31.6	-15.1	38.8	40.7	53.9	15.1	13.2	Inside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

*No signal detected at 9kHz - 30MHz.

* Third harmonics was not detected.

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-20dB and 99% Occupied Bandwidth

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. 33AE0086-HO-01
Date 08/19/2012
Temperature/ Humidity 22 deg. C / 71% RH
Engineer Shinya Watanabe
Mode Transmitting mode, FSK / ASK (433.92MHz)

Bandwidth Limit : Fundamental Frequency **433.92** MHz x 0.25% = 1084.80 kHz

FSK

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
86.778	1084.80	Pass

ASK

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
28.824	1084.80	Pass

Bandwidth Limit : Fundamental Frequency **433.92** MHz x 0.25% = 1084.80 kHz

FSK

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
85.66	1084.80	Pass

ASK

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
96.79	1084.80	Pass

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Head Office EMC Lab.

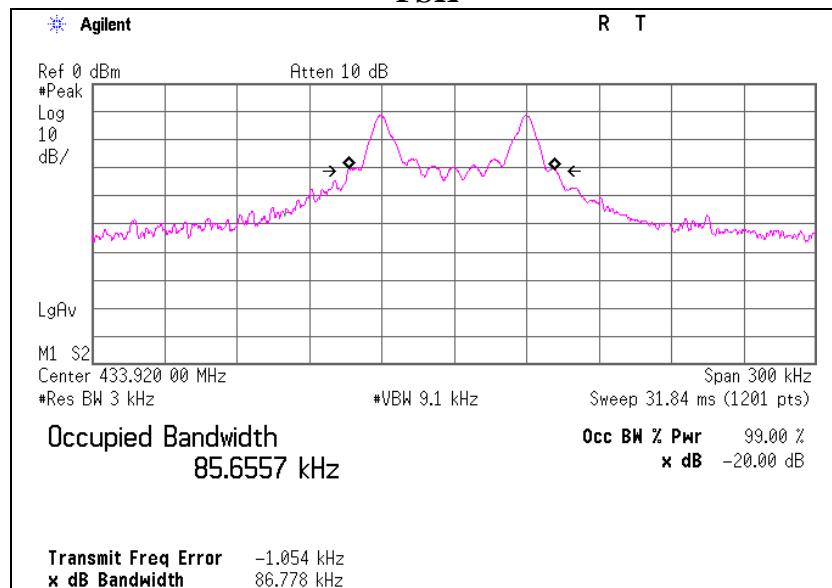
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

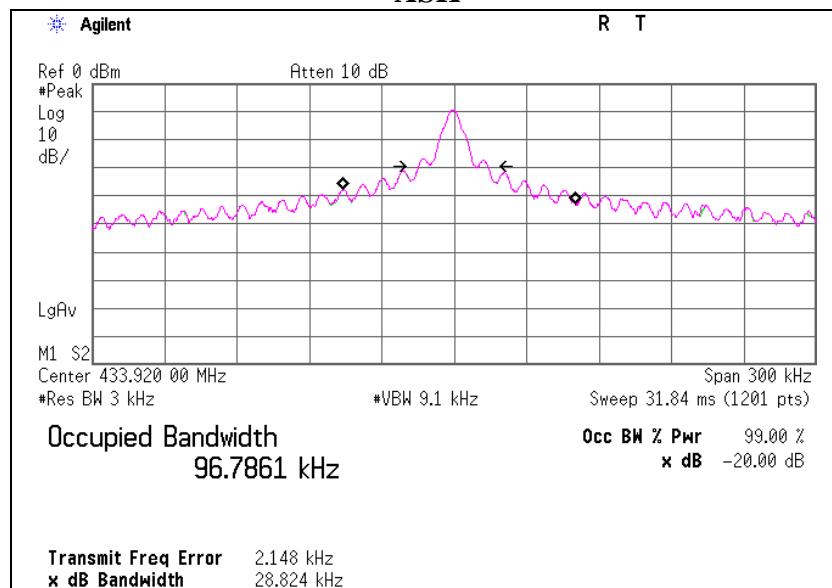
Facsimile : +81 596 24 8124

-20dB and 99% Occupied Bandwidth

FSK



ASK



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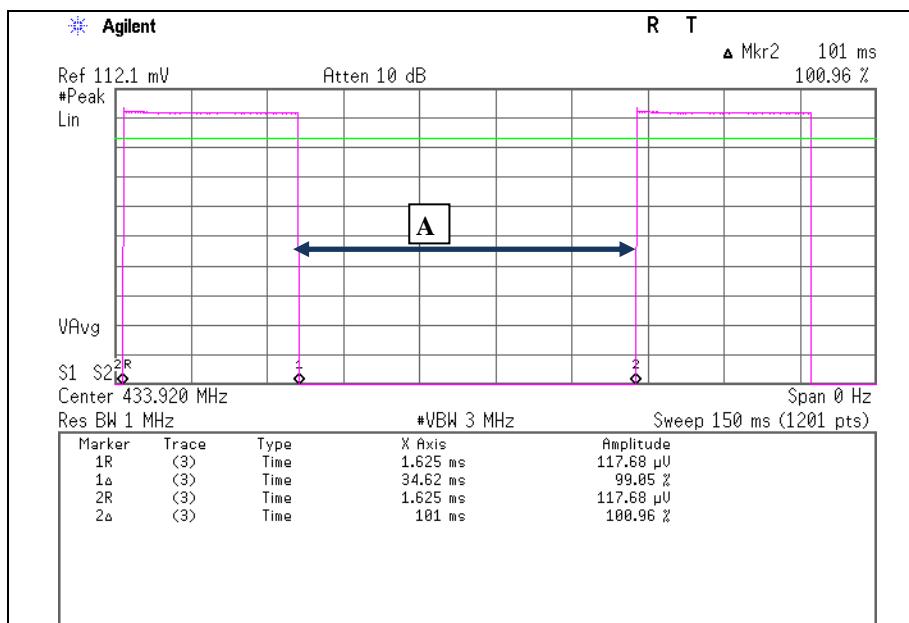
Duty Cycle

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
 Report No. 33AE0086-HO-01
 Date 08/19/2012
 Temperature/ Humidity 22 deg. C / 71% RH
 Engineer Shinya Watanabe
 Mode Transmitting mode, FSK (433.92MHz)

(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
34.620	101.00	0.3462	-9.21

Duty = $20\log_{10}(\text{ON time}/100\text{ms})$



*A is intentional off time.

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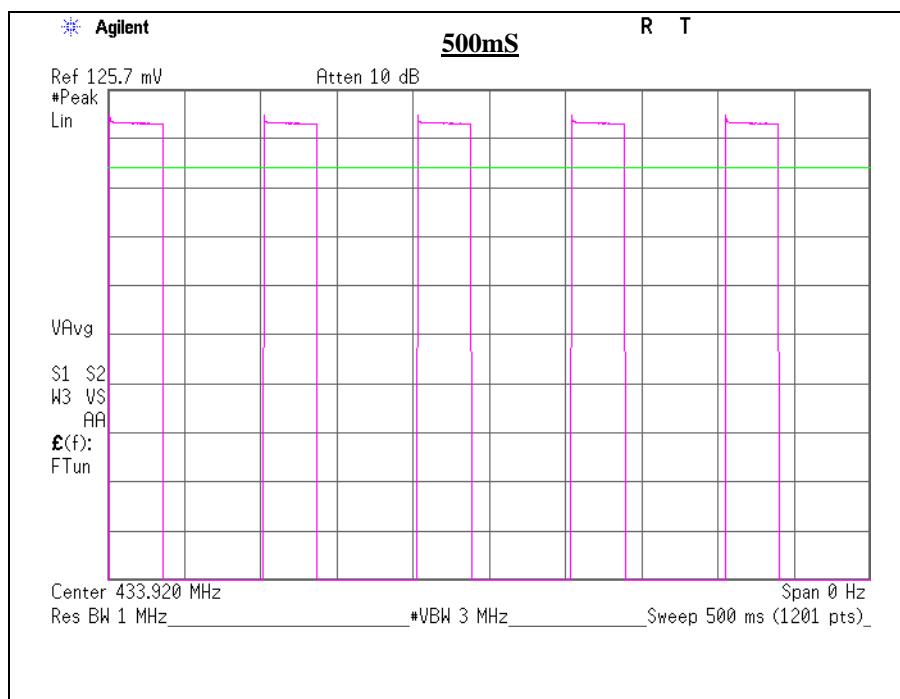
Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

Duty Cycle



Duty Cycle

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
 Report No. 33AE0086-HO-01
 Date 08/19/2012
 Temperature/ Humidity 22 deg. C / 71% RH
 Engineer Shinya Watanabe
 Mode Transmitting mode, ASK (433.92MHz)

Type	Times	ON time(One pulse) [ms]	ON time(in 100ms) [ms]
A	58	0.123	7.134
B	43	0.242	10.406

*1)ON time(in 100ms) = Times * ON time(One pulse)

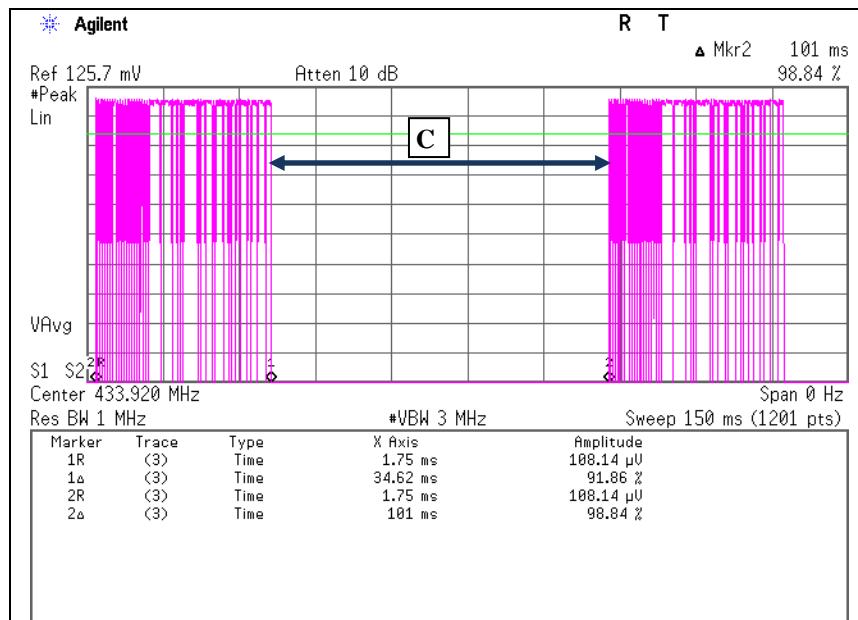
*2)The train of pulses was exceeding 100msec, and that sampled 100msec was the worst case against the pulse train

(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
17.540	101.00	0.1754	-15.12

*3)ON time = Type A's ON time (in 100ms) + Type B's ON time (in 100ms)

*4)Duty = $20\log_{10}(\text{ON time}/100\text{ms})$



*C is intentional off time.

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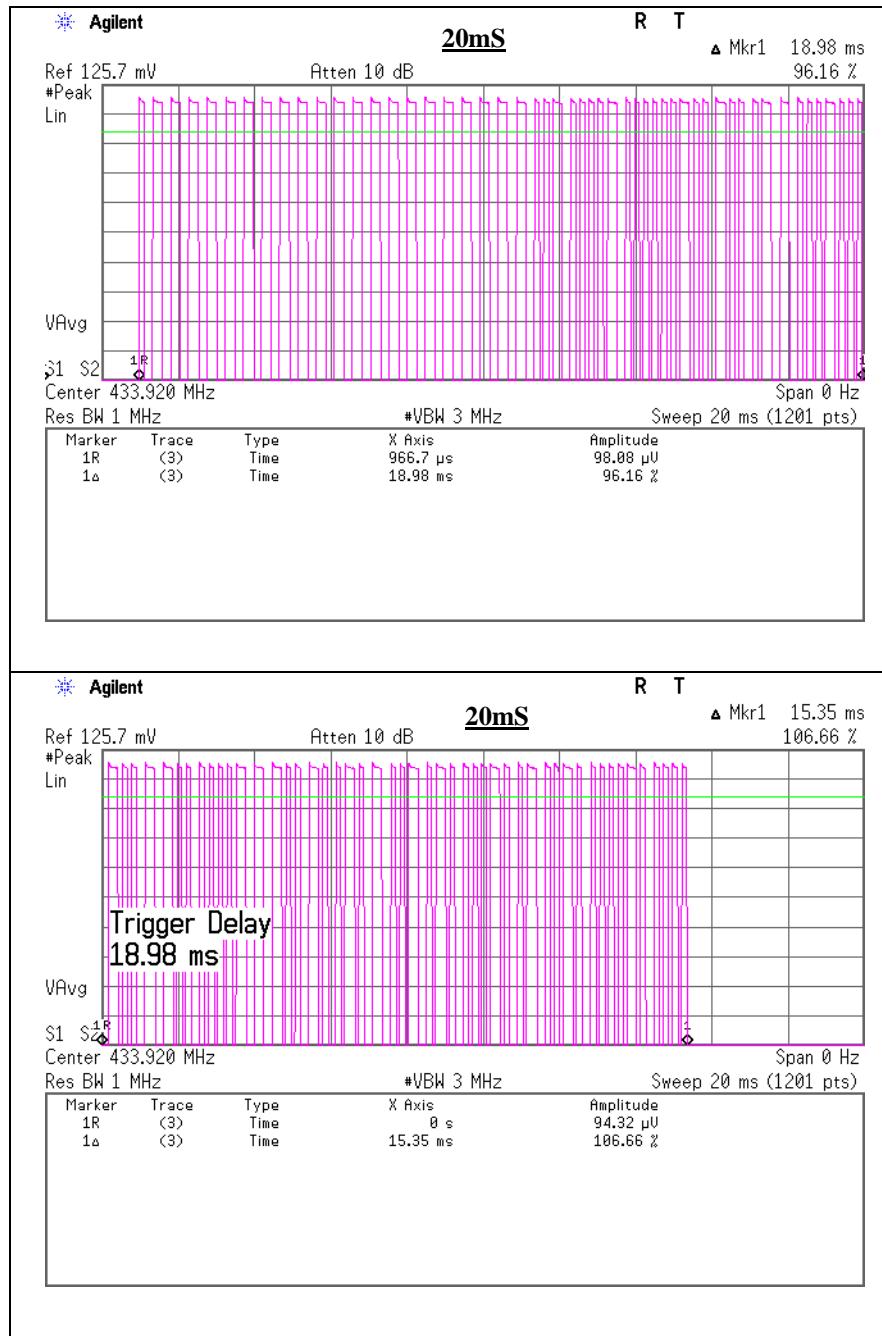
Head Office EMC Lab.

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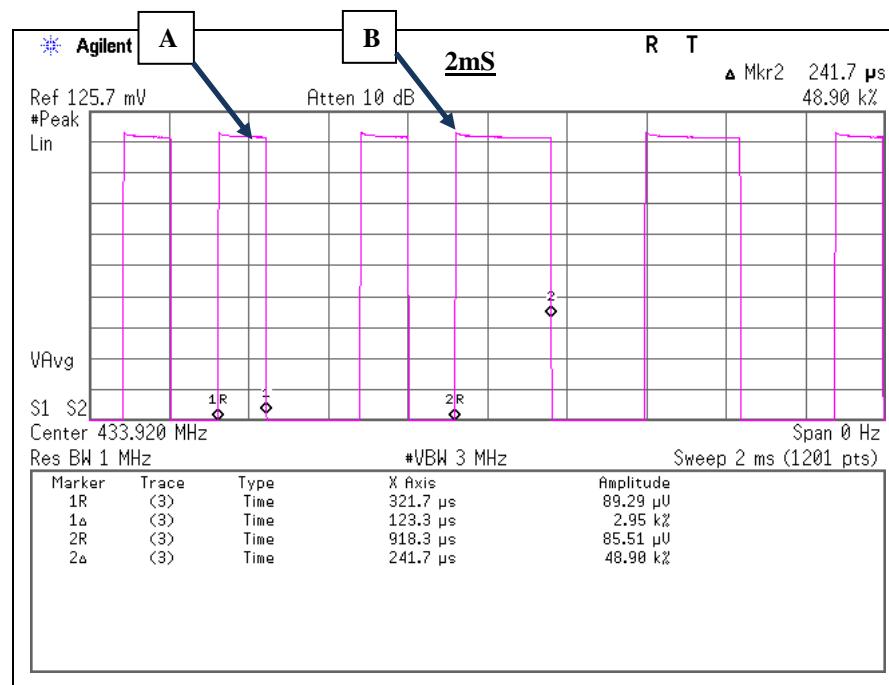
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Duty Cycle



Duty Cycle



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APPENDIX 2:Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2012/02/29 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	-	RE	2012/02/06 * 12
MJM-07	Measure	PROMART	SEN1955	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE	2011/08/11 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2011/11/16 * 12
MLA-08	Logperiodic Antenna	Schwarzbeck	UKLP9140-A	N/A	RE	2011/11/16 * 12
MCC-50	Coaxial Cable	UL Japan	-	-	RE	2012/06/01 * 12
AT-38	Attenuator	Anritsu	MP721B	6200961025	RE	2011/12/08 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	260833	RE	2012/03/05 * 12
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2012/02/24 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	-	RE	2012/02/06 * 12
MJM-15	Measure	KOMELON	KMC-36	-	RE	-
MSA-10	Spectrum Analyzer	Agilent	E4448A	MY46180655	RE	2012/02/03 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2012/05/25 * 12
MCC-133	Microwave Cable	HUBER+SUHNER	SUCOFLEX104	336164/4(1m) / 340640(5m)	RE	2011/09/07 * 12
MPA-11	MicroWave System Amplifier	Agilent	83017A	MY39500779	RE	2012/03/29 * 12
MLPA-06	Loop Antenna	UL Japan	-	-	-	Pre Check

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth , Automatically deactivate and Duty cycle tests

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